

Application/Control No.	Applicant(s)/Patent under Reexamination
10/766,993	CHANG ET AL.
Examiner	Art Unit
ANOOP SINGH	1632

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT Search report seperately attached	2/8/2009	AKS		
STN, Embase, Medline, Caplus, Biosis; Search report seperately attached	2/8/2009	AKS		
PALMInventor Name Search	2/8/2009	AKS		
TIC seqeunce search		AKS		